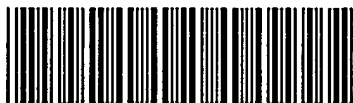


Search Notes

Application/Control No.

10/663,698

Examiner

B. Chen

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner
updated	previous	2/9/2006	BC
427	130		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
427	128	2/9/2006	BC
	130 131		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/9/2006	BC